



TCC Tidbits

Patents in Microwave Measurement—Nonlinear Transmission Lines

■ Mark Kahrs

This column is the first in a series devoted to patents and microwave measurement. Although the patent system is abused and misused, it also offers a path to publish design ideas in addition to journals and conferences. Many times, design ideas and concepts only appear in patents. Therefore, in this column, we will look at how studying patents can inform our knowledge of microwave instrumentation and measurement.

The Nonlinear Transmission Line

The topic of this first column is the nonlinear transmission line (NLTL). Due to their application in pulse compression, NLTLs find use as both harmonic and pulse generators in microwave instrumentation, most recently in products from Anritsu [19].

Early Development

Landauer's papers in 1960 [11], [12] pointed out the importance of dispersion in the creation of shockwaves. Afterward, research was steady (Jäger's work [9] using continuous gallium



IMAGE LICENSED BY GRAPHIC STOCK

arsenide (GaAs) lines pushed things along), but it wasn't until Bloom's group at Stanford University produced a crop of Ph.D. dissertations—including Rodwell [22], Van Der Weide [26], and Marsland [13]—that NLTLs were applied to microwave measurement.

Rodwell's first paper appeared in January 1987, but the first patent from Bloom's group was U.S. Patent 5 014 018 [23], filed in October of that year. This initial disclosure by Rodwell describes an integrated NLTL implementation with an LC ladder in GaAs. Another patent was filed just to disclose that the input and output impedances could differ and, therefore, the NLTL could be considered an impedance transformer [4].

Rodwell's work continued with the reimplementation of Grove's sampler [8] (found in U.S. Patent 3 278 763 [7]), using the NLTL as the pulse sharpener. Until the introduction of the NLTL, fast risetime pulses for use as the sampling strobe were limited by the risetime of the tunnel diode and step-recovery diode (SRD) strobe generators. Stanford didn't hesitate to patent the sampler (see U.S. Patents 5 267 020 and 5 378 939, credited to Marsland, Rodwell, and Bloom [14], [15]).

HP's Innovations

Hewlett-Packard (HP) in Palo Alto, California, quickly capitalized on the nearby development by producing the 50-GHz sampler for the 54121T oscilloscope [27]. HP's first patent using this technology came only two months after Rodwell's patent was filed [25]. HP's patent describes how to vary the ratio of dispersion to diode nonlinearity by changing the transmission line length and diode area.

A year later, HP filed the patent for the sampler [24]. It is instructive to compare the two patents: the Stanford patent explicitly describes the use of air bridges, while the HP patent describes (in vague terms) how to implement the balun need to produce balanced sampling stobes.

Mark Kahrs (m.kahrs@ieee.org) is an independent consultant.

Digital Object Identifier 10.1109/MMM.2016.2551499
Date of publication: 6 June 2016

But there is considerable overlap. As shown in Figure 1, HP reimplemented Rodwell's reimplementation of the Grove sampler. The last patent filed by HP during this era describes how "stacked" varactors can be used in the transmission line [3].

Further Innovations

Rodwell moved to the University of California, Santa Barbara, and established a group there that extended his dissertation work. Case [5] and Allen [2] both worked on aspects of fabrication, simulation and design. Yu et al. added an RC termination in parallel with a shorted line [28] that reduces the impedance mismatch and, hence, allows low reflections

and higher efficiency. Case moved to Hughes Research and quickly patented an extension of his dissertation to cover differential NLTLS [6]. By using antiparallel diodes, this NLTTL can compress both rising and falling edges.

PSPL's Work

Picosecond Pulse Lab (PSPL) was founded by National Bureau of Standards researcher Jim Andrews in 1980. Eventually, PSPL expanded to Beaverton, Oregon, and picked off sampling designer A. Agoston from Tektronix. Complete with their own III-V circuit fabricator,

NLTLS find use as both harmonic and pulse generators in microwave instrumentation.

PSPL designed and fabricated a sampling head using the NLTTL technology from Stanford. The full details of their design can be found in a series of patents beginning with U.S. Patent 6 900 710 [1].

This patent covers an NLTTL design with a number of innovations, including the specific use of a nonparallel coplanar waveguide, and also different types of shapes for the transmission line. While it was available, this sampler was the fastest commercial sampler on the market. Figure 2 shows the mask layout of the NLTTL-based sampler. The sampling diodes

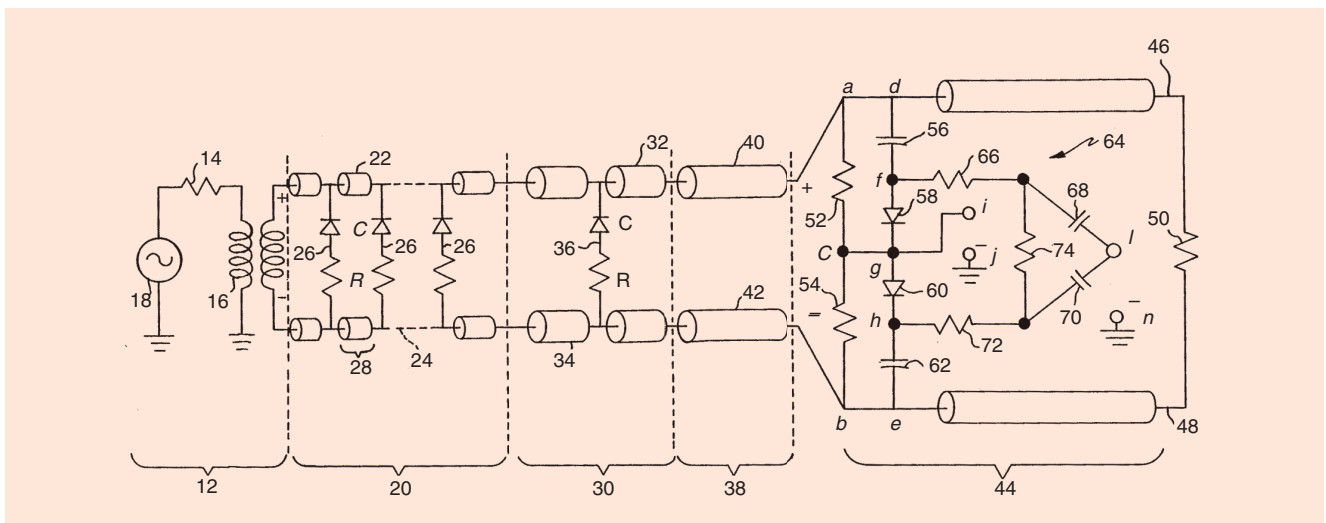


Figure 1. The schematic of HP's NLTTL sampler. (Reproduced from U.S. Patent 4 956 568.)

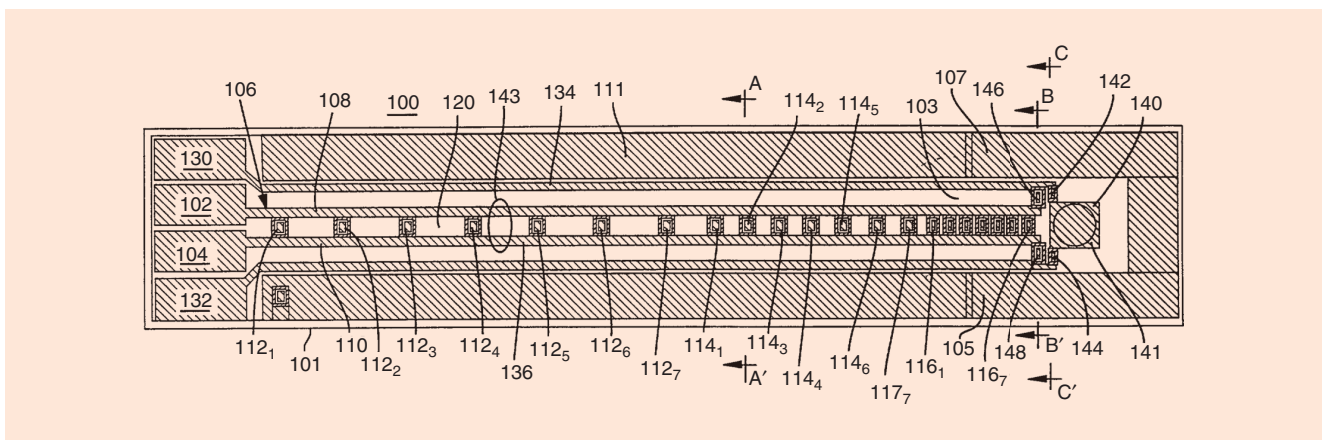


Figure 2. The mask layout of the PSPL NLTTL sampler. (Reproduced from U.S. Patent 7 084 716.)

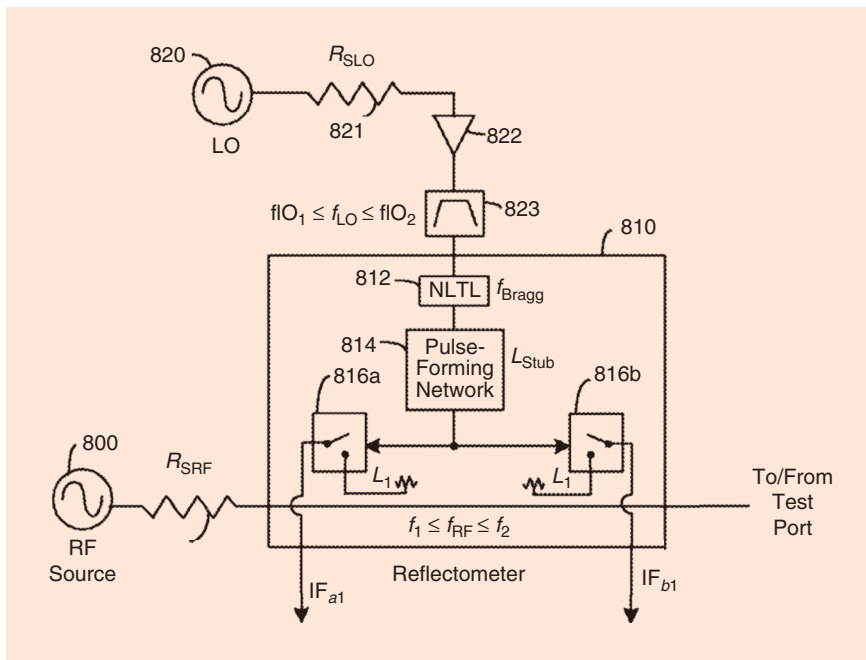


Figure 3. An example of the use of an NLTL in Anritsu's test set. (Reproduced from U.S. Patent 8 417 189.)

are at the right-hand edge, near the connection pad.

Pepper, also of PSPL, showed how to bias an NLTL as a comb generator [21]. Included is a very complete discussion of bias generators as a design approach for both integrated and discrete (hybrid) components.

The Late 1990s and Beyond

In the late 1990s, a group at Northrup Grumman was issued a series of patents devoted to NLTL design and application to radio systems. In U.S. Patent 6 690 247, Kintis et al. [10] describe matching the current/voltage characteristics of the diodes in the transmission line to the input waveform. Additionally, the implementation uses a shorting stub to control the output pulse width.

SRDs are commonly used to generate harmonics in vector network analyzers (VNAs). However, the local oscillator input to the SRD is fundamentally limited due to the transit time of the diode. Additionally, the high harmonic order needed for millimeter-wave measurements will result in an increased noise figure.

Anritsu showed interest in the use of NLTL starting in 2003, with Noujeim's

patent [17] describing ways to reduce shock-wave-to-surface-wave coupling. In particular, the patent describes the use of a coplanar strip over a thickened substrate.

Noujeim also showed that, instead of distributing the output of a SRD to each of the samplers, it is possible to integrate an NLTL with each sampler, thereby reducing the leakage from each channel and increasing the interchannel isolation [20].

Finally, Noujeim and Martens illustrate how an NLTL can be applied in a VNA system in U.S. Patent 8 417 189 [18] (an example is shown in Figure 3). The patent offers three methods for extending the range of a VNA using an NLTL:

- 1) changing the fall time of a shockline output voltage waveform by varying the number of diodes in the shockline while also changing the spacing between diodes
- 2) changing the structure of the pulse-forming network
- 3) changing the local oscillator frequency.

Additionally, Noujeim and Martens show how to extend the dynamic range by controlling the diode bias in U.S. Patent 8 718 586 [16].

Conclusions

As discussed here, patents play a critical role in microwave engineering design and implementation outside of the academic applications described in conferences and journals. Once upon a time, it was very difficult to track down the intellectual threads behind an instrument; now, due to the search tools available on the Internet, it is easy enough for any curious engineer to do so.

Acknowledgment

My thanks to Prof. Mark Rodwell for providing back stories on the history of microwave use of the NLTL.

References

- [1] A. Agoston, J. Ebner, S. Pepper, and D. Pratt, "Ultrafast sampler with non-parallel shockline," U.S. Patent 6 900 710, May 31, 2005.
- [2] S. Allen, "Subpicosecond electrical pulse generation and sampling, Schottky collector RTDs," Ph.D. thesis, Univ. of California, Santa Barbara, 1994.
- [3] W. J. Anklam and W. E. Kunz, "Nonlinear transmission lines having noncommensurate varactor cells," U.S. Patent 5 023 574, June 11, 1991.
- [4] A. D. Black, D. M. Bloom, R. M. Marsland, M. S. Shakouri, and A. F. Podell, "Gallium arsenide monolithically integrated nonlinear transmission line impedance transformer," Oct. 4, 1994.
- [5] M. G. Case, "Nonlinear transmission lines for picosecond pulse, impulse and millimeter-wave harmonic generation," Ph.D. thesis, Univ. of California, Santa Barbara, 1993.
- [6] M. G. Case and G. Raghavan, "Differential nonlinear transmission line circuit," U.S. Patent 5 789 994, Aug. 4, 1998.
- [7] W. M. Grove, "Two diode balanced signal sampling apparatus," U.S. Patent 3 278 763, Aug. 23, 1965.
- [8] W. M. Grove, "Sampling for oscilloscopes and other RF systems: DC through X-band," *IEEE Trans. Microwave Theory Techn.*, vol. 14, no. 12, pp. 629–635, Dec. 1966.
- [9] D. Jäger, "Characteristics of traveling waves along the nonlinear transmission lines for monolithic integrated circuits: A review," *Int. J. Electronics*, vol. 58, no. 4, pp. 649–669, 1985.
- [10] M. Kintis, D. K. Ko, F. S. Fong, and S. A. Maas, "Nonlinear transmission line waveform generator having an input voltage matched to the C/V characteristic of the transmission line," U.S. Patent 6 690 247, Feb. 10, 2004.
- [11] R. Landauer, "Parametric amplification along nonlinear transmission lines," *J. Applied Physics*, vol. 31, no. 3, pp. 479–484, Mar. 1960.
- [12] R. Landauer, "Shock waves in nonlinear transmission lines and their effect on parametric amplification," *IBM Journal*, pp. 391–401, Oct. 1960.
- [13] R. A. Marsland, "Gallium arsenide integrated circuits for measurement and generation of electrical waveforms to 300 GHz," Ph.D. thesis, Stanford Univ., 1990.

- [14] R. A. Marsland, M. Rodwell, and D. M. Bloom, "Gallium arsenide monolithically integrated sampling head using equivalent time sampling having a bandwidth greater than 100 GHz," U.S. Patent 5 267 020, Nov. 30, 1993.
- [15] R. A. Marsland, M. J. W. Rodwell, and D. M. Bloom, "Integrated coplanar strip nonlinear transmission line," U.S. Patent 5 378 939, Oct. 26, 1993.
- [16] J. Martens and K. M. Noujeim, "Apparatus for enhancing the dynamic range of shockline-based sampling receivers," U.S. Patent 8 718 586, May, 6 2014.
- [17] K. Noujeim, "Monolithic nonlinear transmission lines and sampling circuits with reduced shock-wave-to-surface-wave coupling," May 17, 2005.
- [18] K. Noujeim and J. Martens, "Frequency-scalable shockline-based VNA," U.S. Patent 8 417 189, Apr. 9, 2013.
- [19] K. Noujeim, J. Martens, and T. Roberts, "A frequency-scalable NLTL-based signal-source extension," Oct. 10–13, 2011.
- [20] K. M. Noujeim, "Enhanced isolation level between sampling channels in a vector network analyzer," U.S. Patent 7 708 111, Aug. 8, 2006.
- [21] S. H. Pepper, "Biased nonlinear transmission line comb generators," Nov. 3 2009.
- [22] M. J. W. Rodwell, "Picosecond electrical wavefront generation and picosecond optoelectronic instrumentation," Ph.D. thesis, Stanford Univ., 1988.
- [23] M. J. W. Rodwell, M. Kamegawa, R. Yu, M. Case, E. Carman, and K. Giboney, "GaAs nonlinear transmission lines for picosecond pulse generation and millimeter-wave sampling," *IEEE Trans. Microwave Theory and Tech.*, vol. 39, no. 7, pp. 1194–1204, July 1991.
- [24] C.-Y. Su, T. Tan, and W. J. Anklam, "Monolithic sampler," U.S. Patent 4 956 568, Sep. 11, 1990.
- [25] M. Tan, C.-Y. Su, and W. J. Anklam, "Pulse compressor," U.S. Patent 4 855 696, Aug. 8, 1989.
- [26] D. W. V. D. Weide, "All-electronic generation and detection of terahertz free-space radiation with subpicosecond pulses," Ph.D. thesis, Stanford University, 1992.
- [27] W. C. Whiteley, W. E. Kunz, and W. J. Anklam, "50 GHz sampler hybrid utilizing a small shockline and an internal SRD," *IEEE MTT-S Digest*, pp 895–898, 1991.
- [28] R. Y. Yu, M. Case, M. Kamegawa, M. Sundaram, M. J. W. Rodwell, and A. W. Gossard, "275 GHz 3-mask integrated GaAs sampling circuit," *Electronics Lett.*, vol. 26, no. 13, pp. 949–951, June 21 1990.



Get to Know Technical Standards

The foundation for today's global high-tech success



Learn how technical standards develop, grow, and impact today's new global technologies

Explore:

- Educational Programs
- Tutorials
- Case Studies
- Profiles of Developers
- University Courses
- ...and More

Begin your journey into the high-tech world: <http://trystandards.org>

Brought to you by IEEE Standards Education <http://standardseducation.org>

